

**Notic of R ferences Cited**

Application/Control No.

09/910,141

Applicant(s)/Patent Under  
Reexamination  
EMIG ET AL.

Examiner

Kahsay Habte, Ph. D.

Art Unit

1624

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,937,246	06-1990	Sugihara et al.	514/254.11
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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